Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/803,172	SCHERZER, SHIMON B.
Examiner	Art Unit

Temica M. Beamer

2617

	SEARCHED				
Class	Subclass	Date	Examiner		
updated	previous search	1/22/2008	ТМВ		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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